**Product data sheet** 

## 1. General description

The 74ABT541 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT541 device is an octal buffer that is ideal for driving bus lines. The outputs are all capable of sinking 64 mA and sourcing 32 mA. The device features input and outputs on opposite sides of the package to facilitate printed circuit board layout.

## 2. Features and benefits

- Octal bus interface
- Functions similar to the 74ABT241
- Provides ideal interface and increases fan-out of MOS microprocessors
- Efficient pinout to facilitate PC board layout
- 3-State buffer outputs sink 64 mA and source 32 mA
- Live insertion/extraction permitted
- Power-up 3-state
- Latch-up protection exceeds 500 mA per JESD78 class II level A
- ESD protection:
  - HBM JESD22-A114E exceeds 2000 V
  - MM JESD22-A115-A exceeds 200 V

### 3. Ordering information

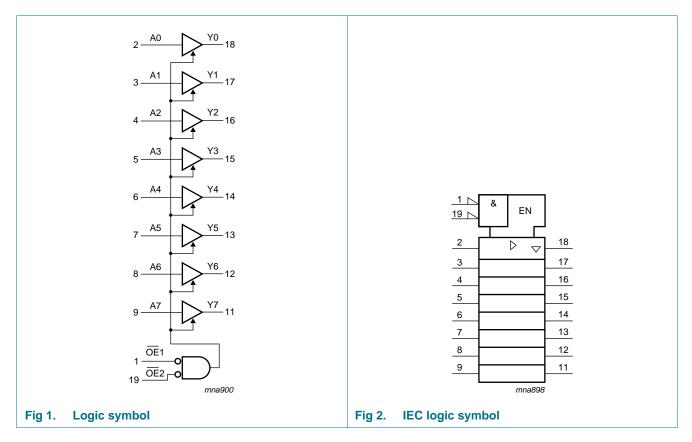
#### Table 1.Ordering information

Type number	Package			
	Temperature range	Name	Description	Version
74ABT541N	–40 °C to +85 °C	DIP20	plastic dual in-line package; 20 leads (300 mil)	SOT146-1
74ABT541D	–40 °C to +85 °C	SO20	plastic small outline package; 20 leads; body width 7.5 mm	SOT163-1
74ABT541DB	–40 °C to +85 °C	SSOP20	plastic shrink small outline package; 20 leads; body width 5.3 mm	SOT339-1
74ABT541PW	–40 °C to +85 °C	TSSOP20	plastic thin shrink small outline package; 20 leads; body width 4.4 mm	SOT360-1



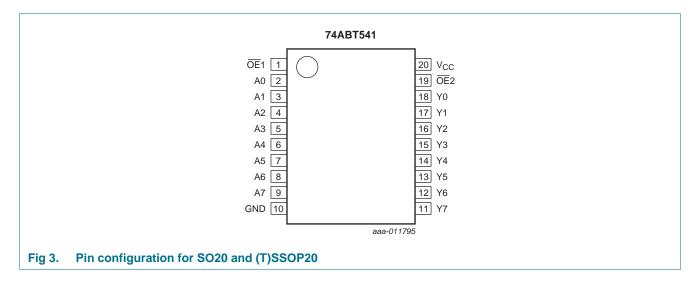
Octal buffer/line driver; 3-state

# 4. Functional diagram



# 5. Pinning information

### 5.1 Pinning



### 5.2 Pin description

Table 2. F	Table 2.         Pin description						
Symbol	Pin	Description					
OE1, OE2	1, 19	output enable input (active LOW)					
A[0:7]	2, 3, 4, 5, 6, 7, 8, 9	data input					
GND	10	ground (0 V)					
Y[0:7]	18, 17, 16, 15, 14, 13, 12, 11	data output					
V <sub>CC</sub>	20	supply voltage					

## 6. Functional description

#### Table 3. Functional table<sup>[1]</sup>

Control		Input	Output
OE1	OE2	An	Yn
L	L	L	L
L	L	Н	Н
Х	Н	Х	Z
Н	Х	X	Z

[1] H = HIGH voltage level; L = LOW voltage level; X = don't care; Z = high-impedance OFF-state.

## 7. Limiting values

#### Table 4.Limiting values<sup>[3]</sup>

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>CC</sub>	supply voltage			-0.5	+7.0	V
VI	input voltage		<u>[1]</u>	-1.2	+7.0	V
Vo	output voltage	output in OFF-state or HIGH-state	[2]	-0.5	+5.5	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < 0 V		-18	-	mA
I <sub>OK</sub>	output clamping current	V <sub>O</sub> < 0 V		-50	-	mA
lo	output current	output in LOW-state		-	128	mA
Tj	junction temperature		[3]	-	150	°C
T <sub>stg</sub>	storage temperature			-65	+150	°C
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40 \text{ °C to } +85 \text{ °C}$	[4]	-	500	mW

[1] The minimum input voltage ratings may be exceeded if the input current ratings are observed.

[2] The output voltage ratings may be exceeded if the output current ratings are observed.

- [3] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

# 8. Recommended operating conditions

#### Table 5.Operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>CC</sub>	supply voltage		4.5	-	5.5	V
VI	input voltage		0	-	V <sub>CC</sub>	V
V <sub>IH</sub>	HIGH-level input voltage		2.0	-	-	V
V <sub>IL</sub>	LOW-level input voltage		-	-	0.8	V
I <sub>OH</sub>	HIGH-level output current		-32	-	-	mA
l <sub>ol</sub>	LOW-level output current		-	-	64	mA
Δt/ΔV	input transition rise and fall rate		0	-	5	ns/V
T <sub>amb</sub>	ambient temperature	in free air	-40	-	+85	°C

# 9. Static characteristics

#### Table 6.Static characteristics

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C			–40 °C t	o +85 °C	Unit
				Min Typ		Max	Min	Min Max	
V <sub>IK</sub>	input clamping voltage	$V_{CC}$ = 4.5 V; I <sub>IK</sub> = -18 mA		-	-0.9	-1.2	-	-1.2	V
V <sub>OH</sub>	HIGH-level output	$V_{I} = V_{IL} \text{ or } V_{IH}$							
	voltage	$V_{CC} = 4.5 \text{ V}; \text{ I}_{OH} = -3 \text{ mA}$		2.5	2.9	-	2.5	-	V
		$V_{CC} = 5.0 \text{ V}; \text{ I}_{OH} = -3 \text{ mA}$		3.0	3.4	-	3.0	-	V
		$V_{CC} = 4.5 \text{ V}; \text{ I}_{OH} = -32 \text{ mA}$		2.0	2.4	-	2.0	-	V
V <sub>OL</sub>	LOW-level output voltage	$\label{eq:V_CC} \begin{array}{l} V_{CC} = 4.5 \; V; \; I_{OL} = 64 \; mA; \\ V_{I} = V_{IL} \; or \; V_{IH} \end{array}$		-	0.42	0.55	-	0.55	V
l <sub>l</sub>	input leakage current	$V_{CC} = 5.5 \text{ V}; \text{ V}_{I} = \text{GND or } 5.5 \text{ V}$	<sub>CC</sub> = 5.5 V; V <sub>I</sub> = GND or 5.5 V		±0.01	±1.0	-	±1.0	μA
I <sub>OFF</sub>	power-off leakage current	$V_{CC}$ = 0.0 V; $V_{I}$ or $V_{O} \leq 4.5$ V	$V_{CC}$ = 0.0 V; V <sub>1</sub> or V <sub>0</sub> $\leq$ 4.5 V		±5.0	±100	-	±100	μA
I <sub>O(pu/pd)</sub>	power-up/power-down output current	$V_{CC}$ = 2.0 V; $V_{O}$ = 0.5 V; V <sub>I</sub> = GND or V <sub>CC</sub> ; $\overline{OE}$ = don't care	<u>[1]</u>	-	±5.0	±50	-	±50	μA
I <sub>OZ</sub>	OFF-state output	$V_{CC}$ = 5.5 V; $V_{I}$ = $V_{IL}$ or $V_{IH}$							
	current	V <sub>O</sub> = 2.7 V		-	5.0	50	-	50	μA
		V <sub>O</sub> = 0.5 V		-	-5.0	-50	-	-50	μA
I <sub>LO</sub>	output leakage current	HIGH-state; $V_0 = 5.5 V$ ; $V_{CC} = 5.5 V$ ; $V_I = GND$ or $V_{CC}$	-		5.0	50	-	50	μA
lo	output current	$V_{\rm CC} = 5.5 \text{ V}; V_{\rm O} = 2.5 \text{ V}$ [2]		-40	-100	-180	-40	-180	mA
I <sub>CC</sub>	supply current	$V_{CC}$ = 5.5 V; $V_{I}$ = GND or $V_{CC}$							
		outputs HIGH-state		-	0.5	250	-	250	μA
		outputs LOW-state		-	24	30	-	30	mA
		outputs disabled		-	0.5	250	-	250	μA

Symbol	Parameter	er Conditions		25 °C			–40 °C te	o +85 °C	Unit
				Min	Тур	Max	Min	Max	
ΔI <sub>CC</sub>	additional supply current	per input pin; output enabled; $V_{CC} = 5.5 V$ ; one input at 3.4 V, other inputs at $V_{CC}$ or GND	[3]	-	0.5	1.5	-	1.5	mA
		per input pin; output disabled; $V_{CC} = 5.5 V$ ; one data input at 3.4 V, other inputs at $V_{CC}$ or GND		-	0.5	50	-	50	μΑ
		per input pin; output disabled; $V_{CC} = 5.5 V$ ; one enable input at 3.4 V, other inputs at $V_{CC}$ or GND		-	0.5	1.5	-	1.5	mA
CI	input capacitance	$V_I = 0 V \text{ or } V_{CC}$		-	4	-	-	-	pF
Co	output capacitance	outputs disabled; $V_0 = 0 V$ or $V_{CC}$		-	7	-	-	-	pF

#### Table 6. Static characteristics ...continued

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

[1] This parameter is valid for any V<sub>CC</sub> between 0 V and 2.1 V, with a transition time of up to 10 ms. From V<sub>CC</sub> = 2.1 V to V<sub>CC</sub> = 5 V  $\pm$  10 %, a transition time of up to 100  $\mu$ s is permitted.

[2] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

[3] This is the increase in supply current for each input at 3.4 V.

# **10.** Dynamic characteristics

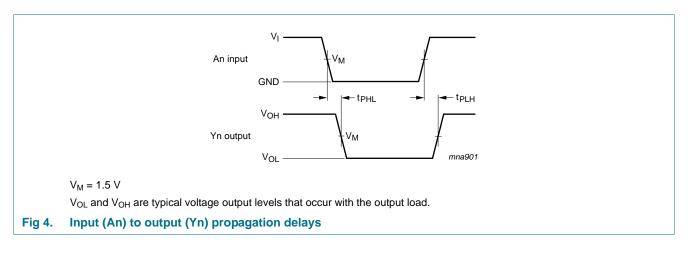
#### Table 7. Dynamic characteristics

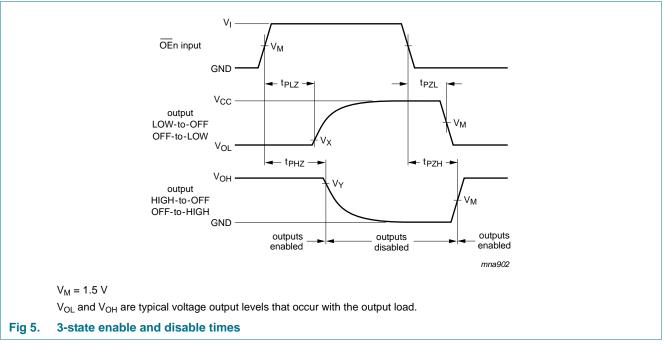
GND = 0 V. Test circuit is shown in <u>Figure 6</u>.

Symbol	Parameter	neter Conditions		25 °C; V <sub>CC</sub> = 5.0 V			–40 °C to +85 °C; V <sub>CC</sub> = 5.0 V ± 0.5 V		
			Min	Тур	Max	Min	Max		
t <sub>PLH</sub>	LOW to HIGH propagation delay	An to Yn, see <u>Figure 4</u>	1.0	2.6	4.1	1.0	4.6	ns	
t <sub>PHL</sub>	HIGH to LOW propagation delay	An to Yn, see <u>Figure 4</u>	1.0	2.9	4.2	1.0	4.6	ns	
t <sub>PZH</sub>	OFF-state to HIGH propagation delay	OEn to Yn; see Figure 5	1.1	3.1	4.8	1.1	5.3	ns	
t <sub>PZL</sub>	OFF-state to LOW propagation delay	OEn to Yn; see <u>Figure 5</u>	2.1	4.4	5.9	2.1	6.4	ns	
t <sub>PHZ</sub>	HIGH to OFF-state propagation delay	OEn to Yn; see Figure 5	2.1	5.1	6.6	2.1	7.1	ns	
t <sub>PLZ</sub>	LOW to OFF-state propagation delay	OEn to Yn; see Figure 5	1.7	4.7	6.2	1.7	6.7	ns	

Octal buffer/line driver; 3-state

# 11. AC waveforms

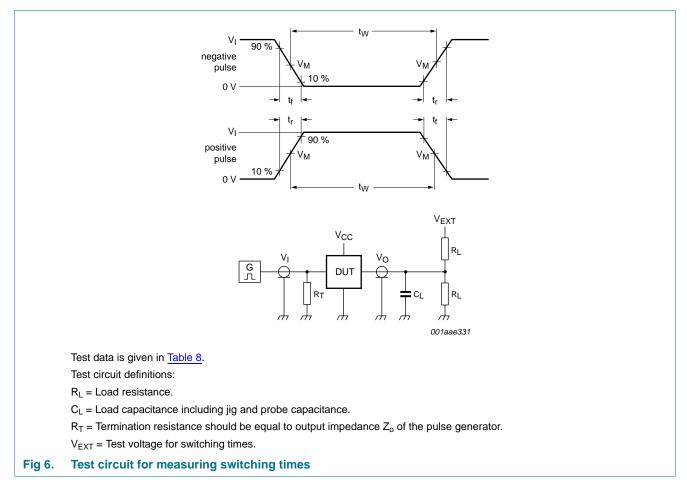




### **NXP Semiconductors**

# 74ABT541

#### Octal buffer/line driver; 3-state

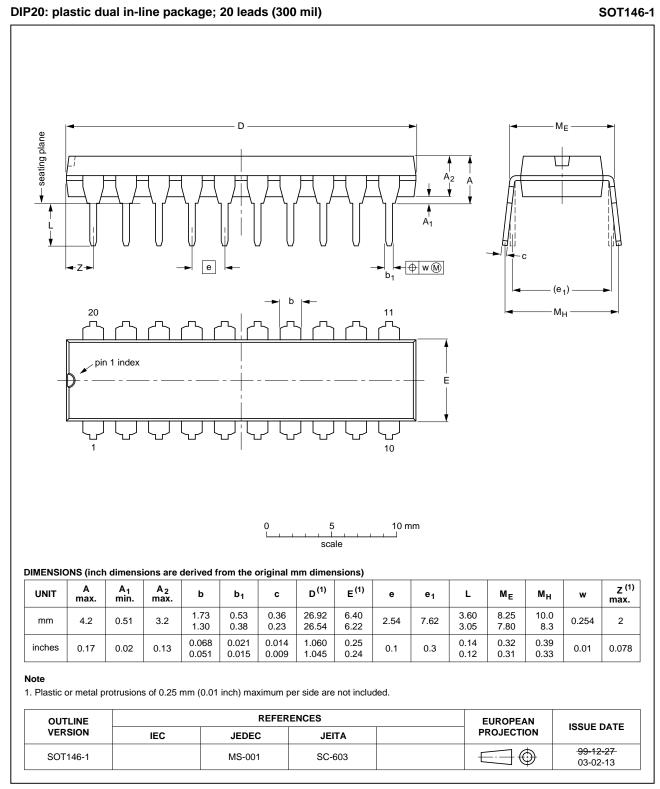


#### Table 8. Test data

Input	nput Load		Load	oad		V <sub>EXT</sub>		
VI	f <sub>l</sub>	t <sub>W</sub>	t <sub>r</sub> , t <sub>f</sub>	CL	RL	t <sub>PHL</sub> , t <sub>PLH</sub>	t <sub>PZH</sub> , t <sub>PHZ</sub>	t <sub>PZL</sub> , t <sub>PLZ</sub>
3.0 V	1 MHz	500 ns	≤ 2.5 ns	50 pF	500 Ω	open	open	7.0 V

Octal buffer/line driver; 3-state

# 12. Package outline



#### Fig 7. Package outline SOT146-1 (DIP20)

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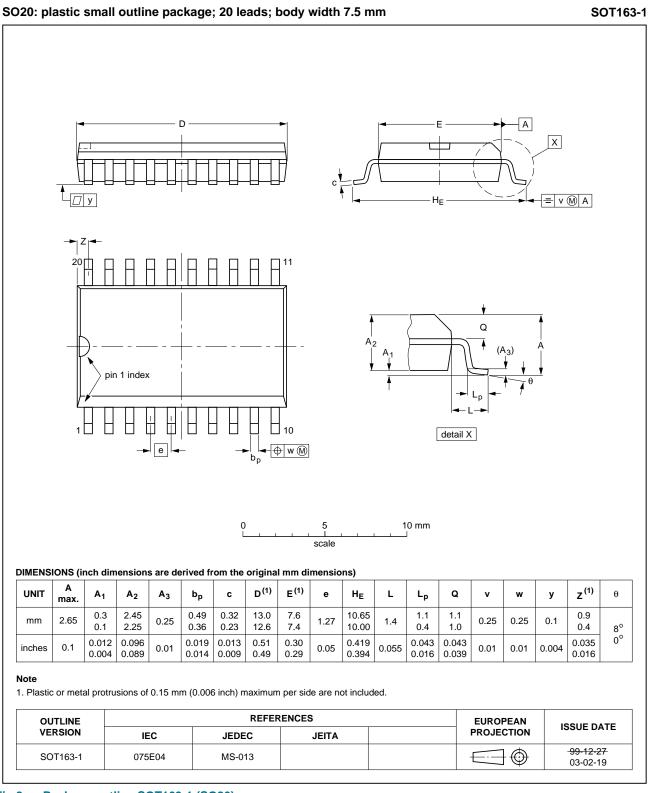
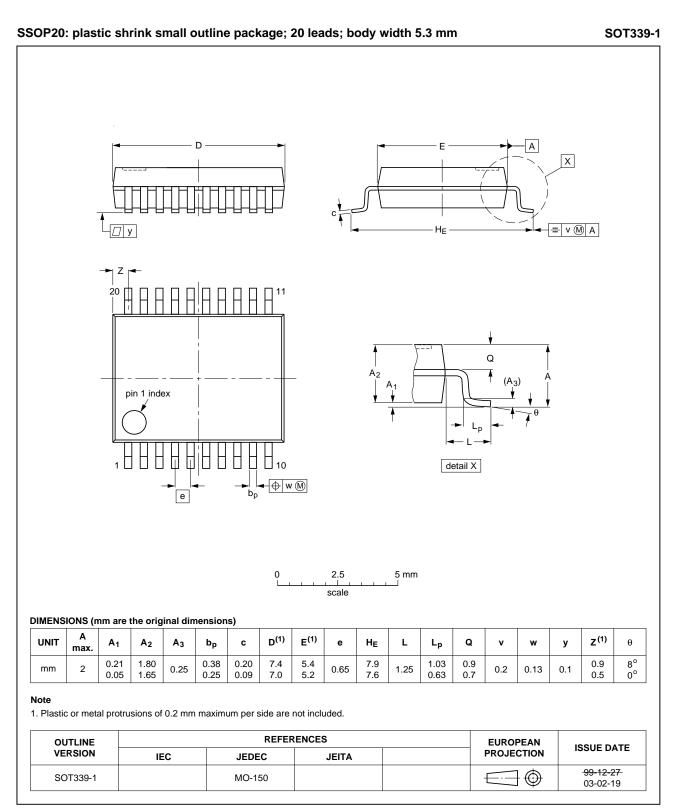
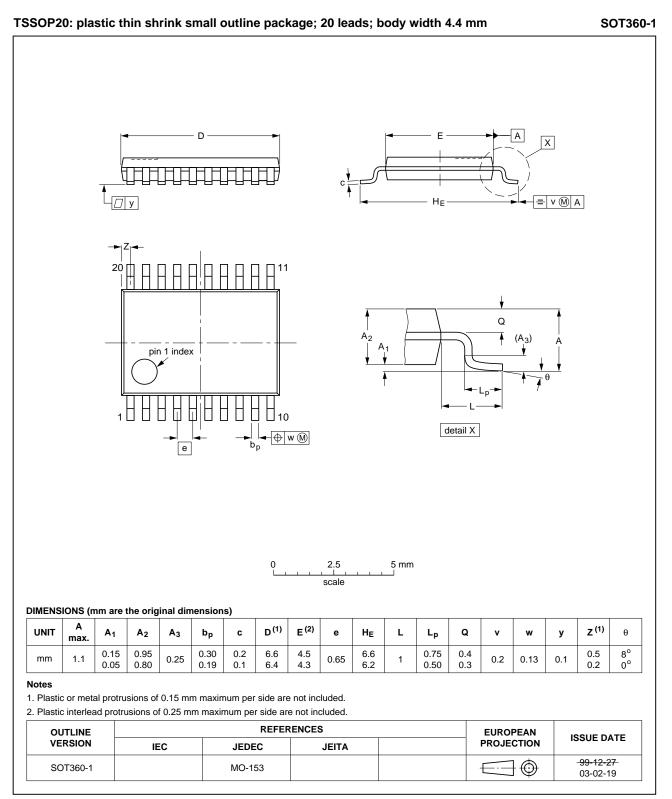


Fig 8. Package outline SOT163-1 (SO20)



#### Fig 9. Package outline SOT339-1 (SSOP20)

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#### Fig 10. Package outline SOT360-1 (TSSOP20)

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# **13. Abbreviations**

Table 9. Abbreviations					
Acronym	Description				
BiCMOS	Bipolar Complementary Metal-Oxide Semiconductor				
CDM	Charged Device Model				
DUT	Device Under Test				
ESD	ElectroStatic Discharge				
НВМ	Human Body Model				
MM	Machine Model				

# 14. Revision history

#### Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
74ABT541 v.3	20140811	Product data sheet	Product data sheet - 7			
Modifications:	guidelines of	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>				
74ABT541 v.2	19980116	Product specification	-	74ABT541 v.1		
74ABT541 v.1	19960110	Product specification		-		

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Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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#### Octal buffer/line driver; 3-state

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